

ADN4670* PRODUCT PAGE QUICK LINKS

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COMPARABLE PARTS

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DOCUMENTATION

Application Notes

- AN-1176: Component Footprints and Symbols in the Binary .Bxl File Format
- AN-1177: LVDS and M-LVDS Circuit Implementation Guide
- AN-1179: Junction Temperature Calculation for Analog Devices RS-485/RS-422, CAN, and LVDS/M-LVDS Transceivers

Data Sheet

- ADN4670: Programmable Low Voltage 1:10 LVDS Clock Driver

DESIGN RESOURCES

- ADN4670 Material Declaration
- PCN-PDN Information
- Quality And Reliability
- Symbols and Footprints

DISCUSSIONS

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ADN4670* PRODUCT PAGE QUICK LINKS

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REVISION HISTORY

1/12—Rev. 0 to Rev. A	
Added LQFP Package.....	Throughout
Updated Outline Dimensions	9
Changes to Ordering Guide	9
4/10—Revision 0: Initial Version	

SPECIFICATIONS

$V_{DD} = 2.375 \text{ V}$ to 2.625 V ; all specifications T_{MIN} to T_{MAX} , unless otherwise noted.

Table 1.

Parameter	Symbol	Min	Typ	Max	Unit	Conditions/Comments
RECEIVER						
Input High Threshold at $\text{CLK0}/\overline{\text{CLK0}}$ or $\text{CLK1}/\overline{\text{CLK1}}$	V_{TH}			100	mV	
Input Low Threshold at $\text{CLK0}/\overline{\text{CLK0}}$ or $\text{CLK1}/\overline{\text{CLK1}}$	V_{TL}	–100			mV	
Differential Input Voltage	$ V_{ID} $	200			mV	
Input Common-Mode Voltage	V_{IC}	$0.5 V_{ID} $		$V_{DD} - 0.5 V_{ID} $		
Input Current at CLK0 , $\overline{\text{CLK0}}$, CLK1 , or $\overline{\text{CLK1}}$	I_{IH} , I_{IL}	–5		+5	μA	$V_I = V_{DD}$ or $V_I = 0 \text{ V}$
Input Capacitance	C_I		3		pF	$V_I = V_{DD}$ or GND
DRIVER						
Differential Output Voltage	$ V_{OD} $	250	450	600	mV	$R_L = 100 \Omega$
V_{OD} Magnitude Change	ΔV_{OD}			50	mV	
Offset Voltage	V_{OS}	0.95	1.2	1.45	V	–40°C to +85°C
V_{OS} Magnitude Change	ΔV_{OS}			350	mV	
Output Short Circuit Current	I_{OS}			–20	mA	$V_O = 0 \text{ V}$
				20	mA	$ V_{OD} = 0 \text{ V}$
Reference Output Voltage	V_{BB}	1.15	1.25	1.35	V	$V_{DD} = 2.5 \text{ V}$, $I = -100 \mu\text{A}$
Output Capacitance	C_O		3		pF	$V_O = V_{DD}$ or GND
SUPPLY CURRENT						
Supply Current	I_{DD}			35	mA	All outputs tristated, $f = 0 \text{ Hz}$
				100	mA	All outputs enabled and loaded, $R_L = 100 \Omega$, $f = 100 \text{ MHz}$
				150	mA	All outputs enabled and loaded, $R_L = 100 \Omega$, $f = 800 \text{ MHz}$

JITTER CHARACTERISTICS

Table 2.

Parameter	Symbol	Min	Typ	Max	Unit	Conditions/Comments
Additive Phase Jitter from Input to LVDS Outputs, Q3 and $\overline{\text{Q3}}$	$t_{JITTER\text{ LVDS}}$		281		$f_s \text{ rms}$	12 kHz to 5 MHz, $f_{OUT} = 30.72 \text{ MHz}$
					$f_s \text{ rms}$	12 kHz to 20 MHz, $f_{OUT} = 125 \text{ MHz}$

LVDS SWITCHING CHARACTERISTICS

$V_{DD} = 2.375 \text{ V}$ to 2.625 V ; all specifications T_{MIN} to T_{MAX} , unless otherwise noted.

Table 3.

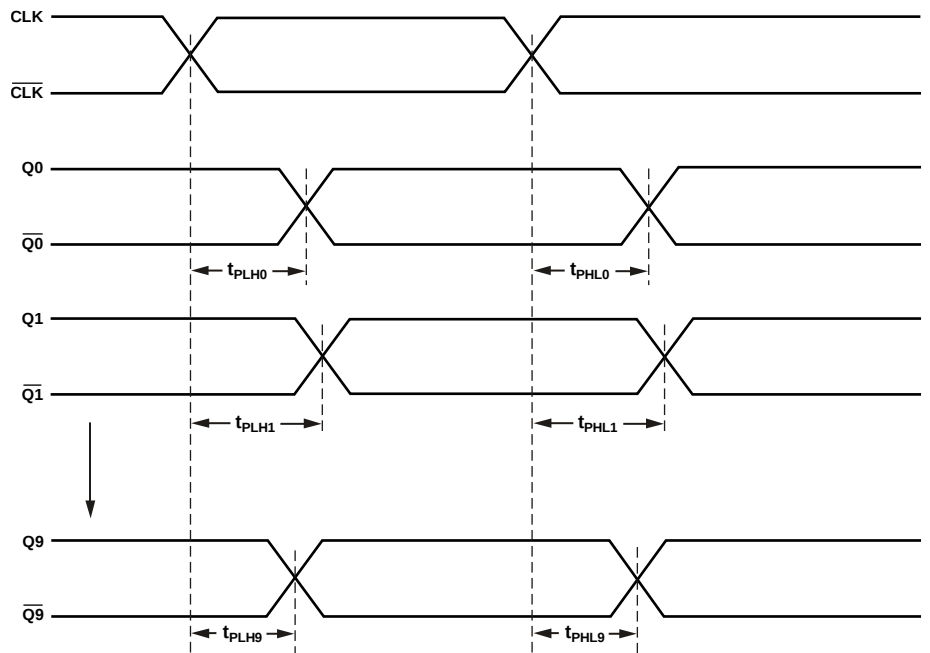
Parameter	Symbol	Min	Typ	Max ¹	Unit	Conditions/Comments
Propagation Delay Low to High	t_{PLHx}		2	3	ns	From $\overline{CLK0}/\overline{CLK0}$ or $CLK1/\overline{CLK1}$ to any $Qx/\overline{Qx}$
Propagation Delay High to Low	t_{PHLx}		2	3	ns	From $\overline{CLK0}/\overline{CLK0}$ or $CLK1/\overline{CLK1}$ to any $Qx/\overline{Qx}$
Duty Cycle	t_{DUTY}	45		55	%	From $\overline{CLK0}/\overline{CLK0}$ or $CLK1/\overline{CLK1}$ to any $Qx/\overline{Qx}$
Output Skew ²	$t_{SK(O)}$		30		ps	Any $Qx/\overline{Qx}$
Pulse Skew ³	$t_{SK(P)}$			50	ps	Any $Qx/\overline{Qx}$
Part-to-Part Output Skew ⁴	$t_{SK(PP)}$			600	ps	Any $Qx/\overline{Qx}$
Output Rise Time	t_r			350	ps	Any $Qx/\overline{Qx}$, 20% to 80%, $R_L = 100 \Omega$ $C_L = 5 \text{ pF}$
Output Fall Time	t_f			350	ps	Any $Qx/\overline{Qx}$, 80% to 20%, $R_L = 100 \Omega$ $C_L = 5 \text{ pF}$
Maximum Input Frequency	f_{CLK}	900	1100		MHz	From $\overline{CLK0}/\overline{CLK0}$ or $CLK1/\overline{CLK1}$ to any $Qx/\overline{Qx}$

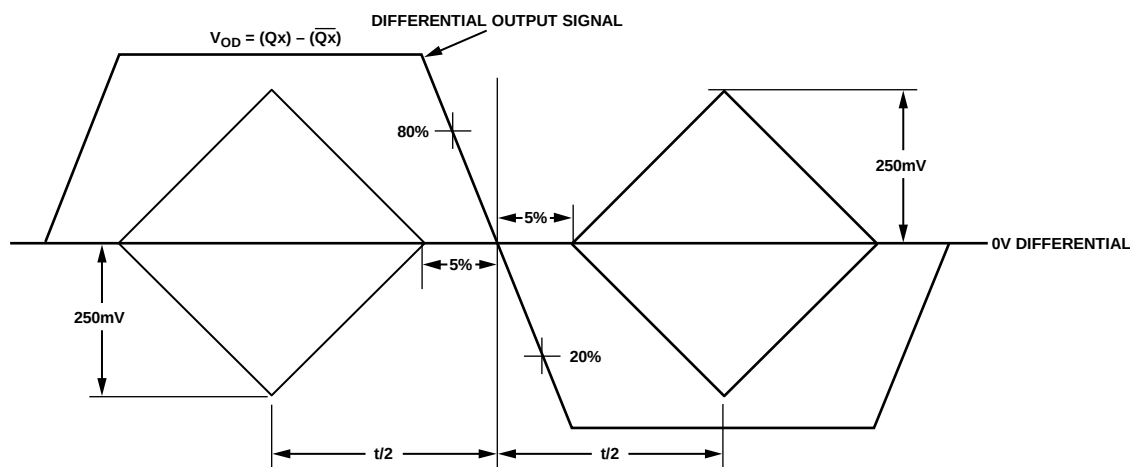
¹ Guaranteed by design and characterization.

² Output skew is defined as the difference between the largest and smallest values of t_{PLHx} within a device or the difference between the largest and smallest values of t_{PHLx} within a device, whichever of the two is greater.

³ Pulse skew is defined as the magnitude of the maximum difference between t_{PLH} and t_{PHL} for any channel of a device, that is, $|t_{PHLx} - t_{PLHx}|$.

⁴ Part-to-part output skew is defined as the difference between the largest and smallest values of t_{PLHx} across multiple devices or the difference between the largest and smallest values of t_{PHLx} across multiple devices, whichever of the two is greater.

Figure 2. Waveforms for Calculation of $t_{SK(O)}$ and $t_{SK(PP)}$

Figure 3. Test Criteria for f_{CLK} , t_r , t_f , and V_{OD}

08870-003

PROGRAMMING LOGIC AC CHARACTERISTICS

$V_{DD} = 2.375 \text{ V}$ to 2.625 V ; all specifications T_{MIN} to T_{MAX} , unless otherwise noted.

Table 4.

Parameter	Symbol	Min	Typ	Max	Unit	Conditions/Comments
Maximum Frequency at CK Input	f_{MAX}	100	150		MHz	
Setup Time, SI to CK	t_{SU}			2	ns	Time for which SI must not change before the CK 0-to-1 transition
Hold Time, CK to SI	t_H			1.5	ns	Time for which SI must not change after the CK 0-to-1 transition
EN to CK Removal Time	$t_{REMOVAL}$			1.5	ns	Removal time, EN to CK
Start-Up Time	$t_{STARTUP}$			1	μs	Start-up time after disable through SI
Minimum Clock Pulse Width	t_W	3			ns	
Logic Input High Level	V_{IH}	2			V	$V_{DD} = 2.5 \text{ V}$
Logic Input Low Level	V_{IL}			0.8	V	$V_{DD} = 2.5 \text{ V}$
High Level Logic Input Current, CK	I_{IH}	-5		+5	μA	$V_I = V_{DD}$
High Level Logic Input Current, SI and EN		+10		-30	μA	$V_I = V_{DD}$
Low Level Logic Input Current, CK	I_{IL}	-10		+30	μA	$V_I = GND$
Low Level Logic Input Current, SI and EN		-5		+5	μA	$V_I = GND$

ABSOLUTE MAXIMUM RATINGS

$T_A = 25^\circ\text{C}$, unless otherwise noted.

Table 3.

Parameter	Rating
V_{CC} to GND	$-0.3\text{ V to }+2.8\text{ V}$
Input Voltage to GND	$-0.2\text{ V to } (V_{DD} + 0.2)\text{ V}$
Output Voltage to GND	$-0.2\text{ V to } (V_{DD} + 0.2)\text{ V}$
Operating Temperature Range	
Industrial	$-40^\circ\text{C to }+85^\circ\text{C}$
Storage Temperature Range	$-65^\circ\text{C to }+150^\circ\text{C}$
Junction Temperature (T_J max)	150°C
Power Dissipation	$(T_J \text{ max} - T_A)/\theta_{JA}$
LFCSP Package	
θ_{JA} Thermal Impedance	32.5°C/W
LQFP Package	
θ_{JA} Thermal Impedance	59°C/W
Reflow Soldering Peak Temperature	
Pb-Free	$260^\circ\text{C} \pm 5^\circ\text{C}$
ESD (Human Body Model, $1.5\text{ k}\Omega$ 100 pF)	4000 V

Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions above those indicated in the operational section of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

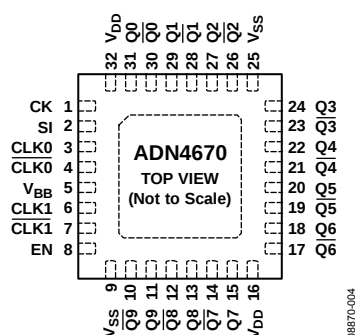
ESD CAUTION



ESD (electrostatic discharge) sensitive device.

Charged devices and circuit boards can discharge without detection. Although this product features patented or proprietary protection circuitry, damage may occur on devices subjected to high energy ESD. Therefore, proper ESD precautions should be taken to avoid performance degradation or loss of functionality.

PIN CONFIGURATION AND FUNCTION DESCRIPTIONS



NOTES
1. THE EXPOSED PAD CAN BE CONNECTED TO GROUND OR LEFT FLOATING.

Figure 4. Pin Configuration

Table 4. Pin Function Descriptions

Pin No.	Mnemonic	Description
1	CK	Programming Clock. Programming data is clocked in on a low-to-high transition at this input. If left open-circuit, it is pulled high by a 120 kΩ resistor.
2	SI	Serial Data Input. This is the input for programming data. If left open-circuit, it is pulled low by a 120 kΩ resistor.
3	CLK0	Noninverting Differential Clock Input 0.
4	$\overline{\text{CLK0}}$	Inverting Differential Clock Input 0.
5	V _{BB}	Reference Voltage Output.
6	CLK1	Noninverting Differential Clock Input 1.
7	$\overline{\text{CLK1}}$	Inverting Differential Clock Input 1.
8	EN	Active-High Enable Input. When this input is high, programming is enabled. If left open-circuit, it is pulled low by a 120 kΩ resistor.
9, 25	V _{SS}	Device Ground.
10, 12, 14, 17, 19, 21, 23, 26, 28, 30	$\overline{\text{Q9}}$ to $\overline{\text{Q0}}$	Inverted Clock Output. When the differential input voltage is between CLKx and $\overline{\text{CLKx}} > 100$ mV, this output sinks current. When the differential input voltage is between CLKx and $\overline{\text{CLKx}} < -100$ mV, this output sources current.
11, 13, 15, 18, 20, 22, 24, 27, 29, 31	Q9 to Q0	Noninverted Clock Output. When the differential input voltage is between CLKx and $\overline{\text{CLKx}} > 100$ mV, this output sources current. When the differential input voltage is between CLKx and $\overline{\text{CLKx}} < -100$ mV, this output sinks current.
16, 32	V _{DD}	Power Supply Input. This part can be operated from 2.375 V to 2.625 V.

THEORY OF OPERATION

The ADN4670 is a clock driver/expander for low voltage differential signaling (LVDS). It takes a differential clock signal of typically 350 mV and expands it to 10 differential clock outputs with very low skew (typically < 30 ps). The device receives a differential current signal from a source such as a twisted pair cable, which develops a voltage of typically ± 350 mV across a 100 Ω terminating resistor. This signal passes via a differential multiplexer to 10 drivers that each output a differential current signal.

The device is programmable using a simple serial interface. One of two differential clock inputs (CLK0/CLK0 or CLK1/CLK1), can be selected and any of the differential outputs (Q0/Q0 to Q9/Q9) can be enabled or disabled.

LVDS RECIEVER INPUT TERMINATION

Terminate the clock inputs with 100 Ω resistors from CLK0 to CLK0 and CLK1 to /CLK1, placed as close as possible to the input pins.

FAIL-SAFE OPERATION

In power-down mode ($V_{DD} = 0$ V), the ADN4670 has fail-safe input and output pins. In power-on mode, fail-safe biasing can be achieved by connecting 10 k Ω pull-up resistors from CLK0 and CLK1 to V_{DD} and 10 k Ω pull-down resistors from CLK0 and CLK1 to GND.

Table 5. Control Logic Truth Table

CK	EN	SI	CLK0	CLK0	CLK1	CLK1	Q0 to Q9	Q0 to Q9
L	L	L	L	H	X	X	L	H
L	L	L	H	L	X	X	H	L
L	L	L	Open	Open	X	X	L	H
L	L	H	X	X	L	H	L	H
L	L	H	X	X	H	L	H	L
L	L	H	X	X	Open	Open	L	H

Table 6. State Machine Inputs

EN	SI	CK	Output
L	L	X	Default state with all outputs enabled, CLK0 selected, and the control register disabled
L	H	X	All outputs enabled, CLK1 selected, and the control register disabled
H	L	↑	First stage stores low, other stage stores data of previous stage
H	H	↑	First stage stores high, other stage stores data of previous stage
L	X	X	Reset the state machine, control register, and shift register

Table 7. Serial Input Sequence

Bit 10	Bit 9	Bit 8	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
CLK_SEL	Q0	Q1	Q2	Q3	Q4	Q5	Q6	Q7	Q8	Q9

Table 8. Control Register

Bit 10	Bit[9:0]	Qx[9:0]
L	H	CLK0
H	H	CLK1
X	L	Outputs disabled

PROGRAMMING

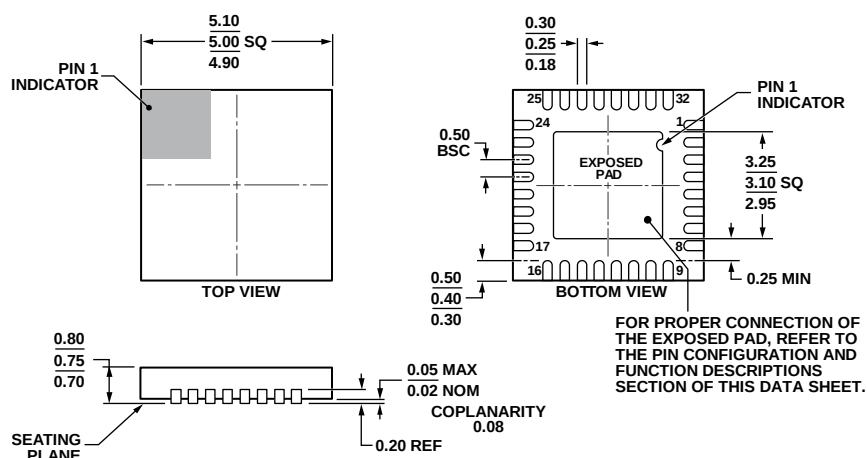
Three control inputs are provided for programming the ADN4670. EN is the enable input, which allows programming when high, SI is the serial data input, and CK is the serial clock input, which clocks data into the device on a low-to-high clock transition. Each of these inputs has an internal pull-up or pull-down resistor of 120 k Ω . EN and SI are pulled low if left open-circuit while CK is pulled high.

The default condition if these inputs are left open-circuit is that all outputs are enabled, and the state of SI selects the inputs (0 = CLK0/CLK0, 1 = CLK1/CLK1). This is the standard operating mode for which no programming of the device is required.

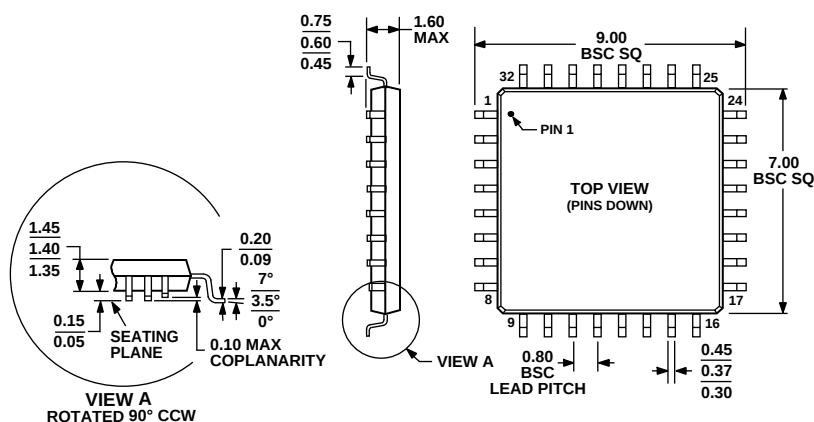
Programming is enabled by taking EN high. The data on SI is then clocked into the device on each 0-to-1 transition of CK. Data on SI must be stable for the setup time (t_{SU}) before the clock transition and remain stable for the hold time (t_H) after the clock transition. To program the device, 11 bits of data are needed, starting with Bit 0, which enables or disables outputs Q9/Q9, through to Bit 10, which selects either CLK0/CLK0 or CLK1/CLK1 as the inputs. A 12th clock pulse is then required to transfer data from the shift register to the control register.

A low-to-high transition on EN resets the control register and the next 12 CK pulses are programmed.

OUTLINE DIMENSIONS



112408-A



ORDERING GUIDE

Model ¹	Temperature Range	Package Description	Package Option
ADN4670BCPZ	-40°C to +85°C	32-Lead Lead Frame Chip Scale Package [LFCSP_WQ]	CP-32-7
ADN4670BCPZ-REEL7	-40°C to +85°C	32-Lead Lead Frame Chip Scale Package [LFCSP_WQ]	CP-32-7
ADN4670BSTZ	-40°C to +85°C	32-Lead Low Profile Quad Flat Package [LQFP]	ST-32-2
ADN4670BSTZ-REEL7	-40°C to +85°C	32-Lead Low Profile Quad Flat Package [LQFP]	ST-32-2

¹ Z = RoHS Compliant Part.

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